Acta Crystallographica Section E Structure Reports Online

ISSN 1600-5368

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Key indicators

Single-crystal X-ray study T = 293 K Mean σ (C–C) = 0.019 Å R factor = 0.080 wR factor = 0.210 Data-to-parameter ratio = 17.5

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

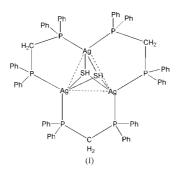
Tris[μ -bis(diphenylphosphino)methane- $\kappa^2 P: P'$]di- μ_3 -sulfanido-trisilver(I) hexafluoroantimonate dichloromethane disolvate

The μ_3 -SH dicapped trisilver compound $[Ag_3(\mu-dppm)_3(\mu_3-SH)_2]SbF_6\cdot2CH_2Cl_2$ [dppm is bis(diphenylphosphino)methane, $C_{25}H_{22}P_2$], formed by the reaction between $[Ag_2(\mu-dppm)_2(MeCN)_2](SbF_6)_2$ and [Pd(phen)(tdt)] (phen is *o*-phenanthroline and tdt is toluene-3,4-dithiolate) through the disruption of C–S bonds, exhibits a trigonal bipyramid core, with two μ_3 -SH ligands at the apices. The Ag atoms are located in tetrahedral environments with P_2S_2 donors.

Received 22 April 2003 Accepted 2 May 2003 Online 9 May 2003

Comment

There is considerable interest in designing novel metal complexes with mixed phosphorus- and sulfur-containing ligands, owing to their unique optical and opto-electronic properties (Yam *et al.*, 2000; Tang *et al.*, 2002). It is well known that S^{2-} and SH^- as versatile coordinating groups could exhibit various bonding modes, to produce metal cluster complexes with diverse structural topologies (Kitagawa *et al.*, 1990; Su *et al.*, 1998). Here we report the crystal structure of a trisilver complex, $[Ag_3(\mu-dppm)_3(\mu_3-SH)_2]SbF_6$, (I), which resulted from the self-assembly between the metal components [Pd(phen)(tdt)] (phen is *o*-phenanthroline and tdt is toluene-3,4-dithiolate) and $[Ag_2(\mu_2-dppm)_2(MeCN)_2](SbF_6)_2$ through the disruption of C–S bonds of tdt.



A perspective drawing of the complex cation, with the atomic numbering scheme, is depicted in Fig. 1 and selected bonding parameters are presented in Table 1. The complex consists of the $[Ag_3(\mu$ -dppm)₃(μ_3 -SH)₂]⁺ cation, an SbF₆⁻ anion and dichloromethane solvent molecules. The μ_3 -SH dicapped trisilver complex exhibits a trigonal bipyramidal core, with two μ_3 -SH ligands in the apices and the three Ag atoms in equatorial sites. The Ag atoms are located in distorted tetrahedral environments with a P₂S₂ donor set. The Ag–Ag distances are in the range 3.337 (1)–3.477 (1) Å, and are shorter than the sum of van der Waals radii for two Ag atoms, indicating a weak metal bonding contact. The Ag–S distances are in the range 2.661 (3)–2.825 (3) Å and the Ag–P bond distances are in the range 2.465 (2)–2.491 (3) Å, close to

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metal-organic papers

those found in other similar complexes of silver (Albano *et al.*, 1999; Meyer *et al.*, 1989; Lang *et al.*, 1993; Henkel *et al.*, 1988).

Experimental

The title compound was isolated from the reaction between $[Ag_2(\mu_2-dppm)_2(MeCN)_2](SbF_6)_2$ (Diez *et al.*, 1987) and [Pd(phen)(tdt)] (Scott & Richard, 1996) in an equimolar ratio in dichloromethane under anaerobic condition for 12 h. Well shaped pale yellow crystals, suitable for X-ray diffraction study, were grown by slow diffusion of diethyl ether into a dichloromethane solution at room temperature.

Crystal data

$[Ag_3(C_{25}H_{22}P_2)_3(HS)_2]SbF_6$	$D_x = 1.597 \text{ Mg m}^{-3}$	
2CH ₂ Cl ₂	Mo $K\alpha$ radiation	
$M_r = 1948.45$	Cell parameters from 8192	
Monoclinic, $P2_1/n$	reflections	
a = 16.0813(1) Å	$\theta = 1.3-25.0^{\circ}$	
b = 18.0049 (2) Å	$\mu = 1.40 \text{ mm}^{-1}$	
c = 28.1089 (3) Å	T = 293 (2) K	
$\beta = 95.4170 \ (10)^{\circ}$	Prism, pale yellow	
$V = 8102.36 (13) \text{ Å}^3$	$0.72 \times 0.60 \times 0.46 \text{ mm}$	
Z = 4		
Data collection		
Siemens SMART CCD	14 088 independent reflections	
diffractometer	10 084 reflections with $I > 2\sigma(I)$	
ω scans	$R_{\rm int} = 0.047$	
Absorption correction: multi-scan	$\theta_{\rm max} = 25.0^{\circ}$	
(SADABS; Sheldrick, 1996)	$h = -10 \rightarrow 19$	
$T_{\min} = 0.354, \ T_{\max} = 0.525$	$k = -13 \rightarrow 21$	
25 151 measured reflections	$l = -33 \rightarrow 32$	
Refinement		

 $\begin{array}{ll} \mbox{Refinement on } F^2 & w = 1/[\sigma^2(F_o^{-2}) + (0.0537P)^2 \\ R[F^2 > 2\sigma(F^2)] = 0.080 & + 77.3298P] \\ wR(F^2) = 0.210 & where \ P = (F_o^{-2} + 2F_c^{-2})/3 \\ S = 1.21 & (\Delta/\sigma)_{\rm max} = 0.006 \\ 14 \ 088 \ {\rm reflections} & \Delta\rho_{\rm max} = 1.50 \ {\rm e} \ {\rm \AA}^{-3} \\ 807 \ {\rm parameters} & \Delta\rho_{\rm min} = -1.23 \ {\rm e} \ {\rm \AA}^{-3} \\ {\rm H-atom \ parameters \ constrained} \\ \end{array}$

Table 1

Selected geometric parameters (Å, °).

Ag1-P2	2.465 (2)	Ag2-S2	2.661 (3)
Ag1-P1	2.465 (2)	Ag2-S1	2.825 (3)
Ag1-S2	2.734 (3)	Ag3-P5	2.483 (3)
Ag1-S1	2.760 (3)	Ag3-P6	2.491 (3)
Ag1-Ag2	3.3369 (11)	Ag3-S1	2.686 (3)
Ag2-P4	2.468 (2)	Ag3-S2	2.771 (3)
Ag2-P3	2.469 (3)		
P2-Ag1-P1	126.27 (8)	P4-Ag2-P3	125.91 (9)
P2-Ag1-S1	96.47 (8)	P3-Ag2-S2	116.19 (9)
P2-Ag1-Ag2	86.89 (6)	P5-Ag3-S2	103.27 (9)
P1-Ag1-Ag2	146.48 (6)	Ag3-S1-Ag1	79.33 (7)
S2-Ag1-Ag2	50.81 (6)	Ag3-S1-Ag2	77.18 (7)
S1-Ag1-Ag2	54.21 (6)	Ag1-S1-Ag2	73.38(7)

All H atoms were included in calculated positions, with C–H distances of 0.93 (sp^2) and 0.97 Å (sp^3), and H–S distances of 1.20 Å. They were included in the refinement in riding motion approximation with $U_{\rm iso} = 1.2U_{\rm eq}$ (1.5 $U_{\rm eq}$ for sp^3) of the carrier atom.

Data collection: *SMART* (Siemens, 1996); cell refinement: *SAINT* (Siemens, 1994); data reduction: *SAINT* and *XPREP* (Siemens,

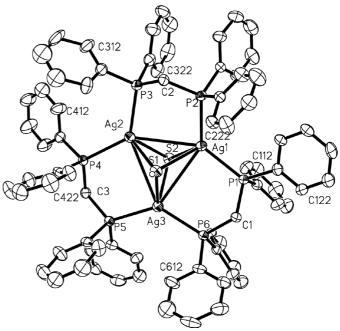


Figure 1

A view of the cation of (I), with the atomic numbering scheme. Displacement ellipsoids are drawn at the 30% probability level.

1994); program(s) used to solve structure: *SHELXTL* (Siemens, 1994); program(s) used to refine structure: *SHELXTL*; molecular graphics: *SHELXTL*; software used to prepare material for publication: *SHELXTL*.

This work was supported by the NSF of China (No. 20171044).

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